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Substitute for form 1449A/B/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>				Complete if Known	
				Application Number	10/812,294-Conf. #1809
				Filing Date	March 29, 2004
				First Named Inventor	Sutherland C. Ellwood, Jr.
				Art Unit	2883
				Examiner Name	T. L. Rude
Sheet	1	of	1	Attorney Docket Number	20028-7002

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
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NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS); title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
TR	CA	D. Budker et al., Resonant Magneto-Optic Rotation: New Twists in an Old Plot [online], [referenced in application and retrieved on 2006-03-29 by Examiner Omar Rojas in US Application 10/906,257]. Retrieved from the Internet: http://ist-socrates.berkeley.edu/~budker/papers/ResonantFaradayPaper/resFar.pdf	

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Examiner Signature	/Timothy Rude/	Date Considered	06/23/2006
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IDS - 04/08/2006 ELECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18

Stylesheet Version v18.0

Title of Invention	Faraday structured waveguide
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Application Number : 10/812294



Confirmation Number: 1809

First Named Applicant: Sutherland Ellwood

Attorney Docket Number: 20028-7002

Art Unit: 2883

Examiner: T. L. Rude

Search string: (5844710 or 5889609 or 5901258 or 6103010 or 6208795 or 6333806 or 6339492 or 6417892 or 6441944 or 6542647 or 6577430 or 6757101 or 6762872 or 6813076 or 20010010593 or 20010023932 or 20010032940 or 20020003651 or 20020044710 or 20020139974 or 20020051279 or 20020063941 or 20030031443).pn

US Patent Documents

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
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	AB*	5889609	1999-03-30	Fukushima, Nobuhiro			
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Signature

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